



**ArC ONE**

Memristor Characterisation Platform

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User Manual



# 1 Introduction

ArC Instruments® delivers high performance testing platforms for characterizing 'en masse' novel technologies in a fast and automated fashion.

ArC ONE® is specifically designed for working with emerging 2-terminal nanoelectronic memory devices. The instrument is controlled through a simple yet powerful user interface that allows for ArC ONE® capabilities to be broadly accessible, from research students to competent test engineers.

ArC ONE® can effortlessly be integrated into any R&D setting to accelerate discovery. It can be used with any probe for accessing from single up to 1024 devices directly on wafer or even be used as a stand-alone portable testing capability to enable advanced in-situ physicochemical characterisation techniques.

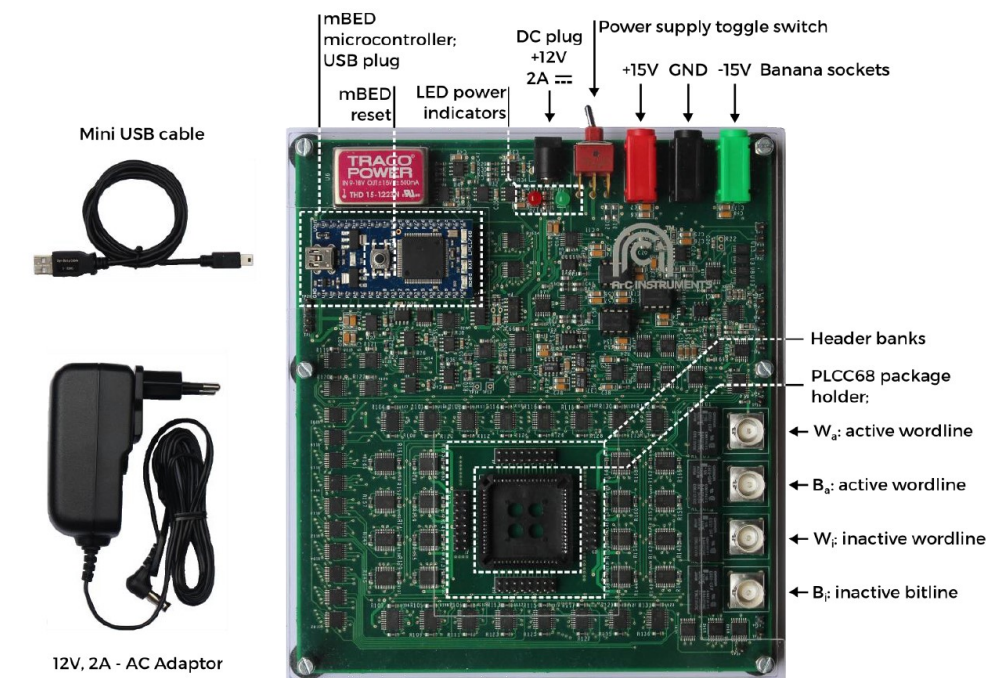
And while this instrument provides unrivalled versatility in testing, it does so without compromising on performance; delivering nanosecond pulsing and other bespoke state-of-art capabilities that are essential for characterising advanced memory devices.

This guide covers the installation of this apparatus and details its capabilities.

## 2 Getting started

### 2.1 Out of the box

The ArC ONE® system consists of a hardware instrumentation board (ArC ONE®) and a dedicated software graphical user interface – GUI (ArC ONE Control®). The hardware and adjacent components straight out of the box are illustrated below



**Fig. 1** - Out of the box: ArC ONE® hardware instrumentation board. Mini USB cable. AC adaptor

To power up the board, either plug in the provided AC power adaptor in the DC plug, or connect a desktop power supply to the banana sockets. Toggle the power supply switch towards the required power supply input. The red and green LEDs should turn on, indicating the board is powered. For best results, utilise a battery supply.

The PLCC socket holds packaged samples. The socket accepts 68-pin ceramic quad flat pack chip carriers (CQFJ). Typical cavity sizes for these packages are (in inches) 0.265×0.265, 0.3×0.3, 0.4×0.4 and 0.46×0.46. Its pin map is illustrated below in Figure 2.

In the case where devices need to be accessed away from the board, (eg via a probe card to solid-state devices on wafer), the surrounding headers provide access to individual word- and bitline addresses.

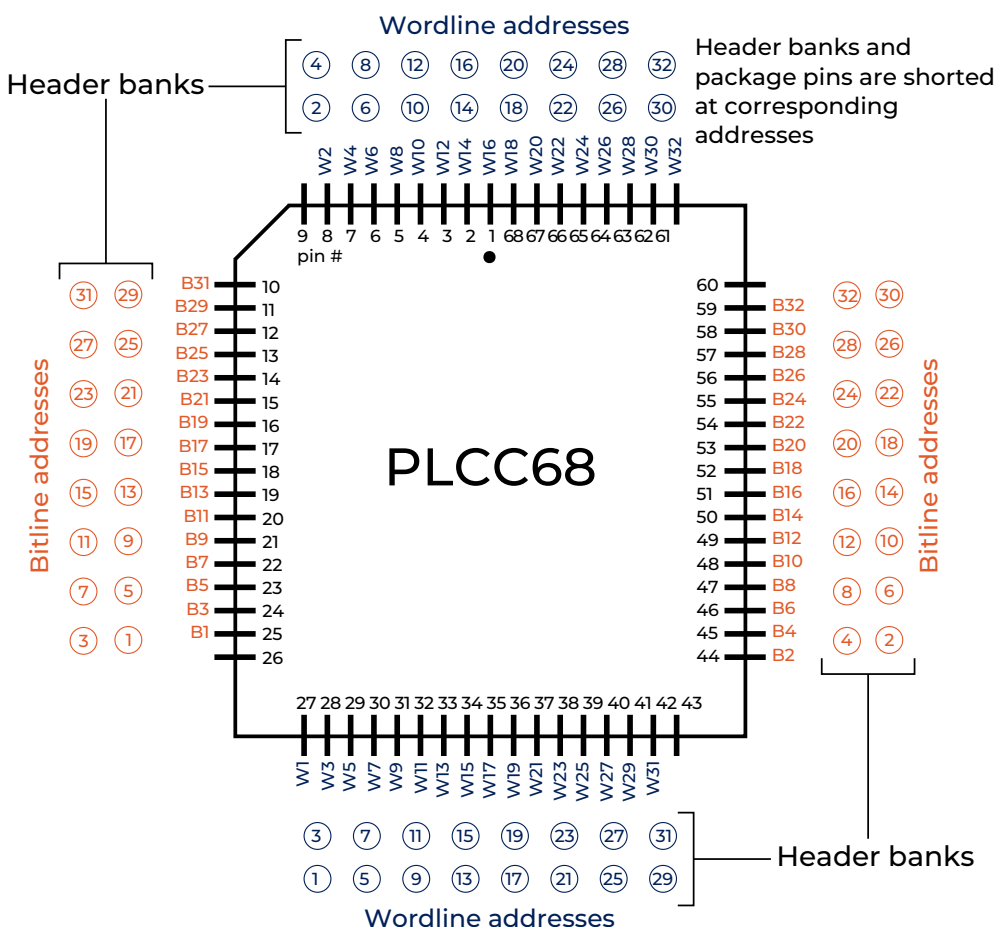


Fig. 2 - PLCC68 and surrounding headers pin map

## 2.2 Software Installation and Update

To install the ArC ONE® Control GUI, follow the steps below: (for Windows 7 and above)

1. Download the source files from: [http://files.arc-instruments.co.uk/release/Arc\\_ONE\\_Control\\_full.zip](http://files.arc-instruments.co.uk/release/Arc_ONE_Control_full.zip)
2. Unzip the files to a folder of your choice.
3. Download mBED drivers from <http://developer.mbed.org/handbook/Windows-serial-configuration> and follow steps 1 and 2 to install the drivers
4. You're good to go. Double click on ArC ONE Control.exe in the ArC ONE Control folder to start the interface. Connect your PC to the board via the USB cable and plug in the provided DC adaptor. If you notice any anomalies, reset the mBED.

To update the ArC ONE® Control GUI suite, first start the interface, make sure the ArC ONE® board is connected via USB and look for the Platform Manager launch button on the top left corner of the GUI. An internet connection is required for this feature.

If the button is active, then an update is available. Click the button to start the automatic updater. You can manually check for updates at *Settings » Check for updates*.

## 3 Using the ArC ONE® Control GUI

The ArC ONE® Control GUI is distributed under the General Public License (GNU) Version 3. It is therefore an open-source copy, allowing any user to modify and re-utilise its contents, as long as the original creator is mentioned. Keep a copy of the initial source file to ensure the operation of the ArC® platform.

### 3.1 At a Glance

The ArC GUI allows easy control of the ArC ONE® platform. It is divided into a number of functional panels:

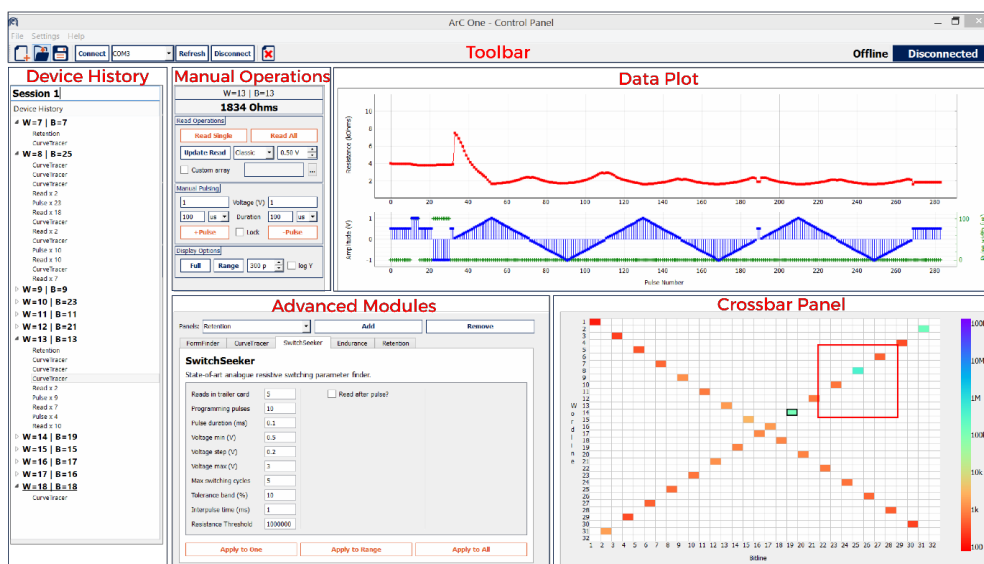


Fig. 3 - At a glance — functional panels of the ArC ONE® GUI

**Toolbar:** contains buttons for saving data, creating, opening and clearing a session, ArC ONE® connection management as well as a GUI session mode indicator (refer to Section 3.3) and an ArC ONE® connection indicator, on the right hand side. File menu contains Save, Open, Clear and Exit options. Settings menu allows the user to modify hardware settings and choose a new working directory on the fly. Help menu shows the documentation (this file), and ArC Instruments Ltd. contact information.

**Manual Operations panel:** Contains buttons for reading a single selected cell or the full array. The Custom Array checkbox restricts the crossbar active devices to any combination of devices in a 32x32 array, based on a text file. The read type can be changed via the drop down menu. The reading voltage can also be set via the input text field. Clicking 'Update' updates the reading method on the ArC ONE® board. Manual pulsing of 0 to  $\pm 12V$  and down to 90ns can be applied on the selected device by pressing +Pulse (positive pulse) or -Pulse (negative pulse). Separate input fields allow for independent setting of positive and negative pulsing polarities.

**Crossbar Panel:** Direct selection of individual devices is performed by left clicking the required position. The selected crosspoint is highlighted by a thick black outline and represents the current device under test (DUT) for any further operation. The resistive state of each device is represented by the colour of the cell, and the colour coding is illustrated at the right of the crossbar. Hovering over a cross-point reveals the absolute resistance value of the last read operation. Additionally, left clicking and dragging allows selection of a square region of devices in a crossbar if local testing is required.

**Data Plot panel:** Top plot shows the resistive state evolution of a device. Bottom plot shows the pulse amplitude and pulse duration per pulse number in chronological order. During the application of an automated pulsing script, the plot is updated live with incoming measurement data.

**Device History panel:** Contains the pulsing history for each device in the crossbar, if any is available. History entries can be accessed to display additional measurement results.

**Pulsing Modules panel:** The drop-down menu contains a number of custom pulsing scripts, and selecting one displays its corresponding options which the user can then set. Panels include custom device operation scripts

such as FormFinder, SwitchSeeker, standard IV measurement protocols such as CurveTracer, and memristor specific characterisation pulsing scripts such as Endurance and Retention. The pulsing scripts are described in detail in Section 3.5.

## 3.2 Starting a new Session

On starting the GUI, the window on the right below will appear which allows setting up a new measurement session. There are 2 main setting categories:

### General settings

The *Session Mode* dropdown selects the operating mode of the system and four options:

1. **Live: Local** – normal operation mode, all outputs are applied to the on-board package holder, and to the surrounding headers.
2. **Live: External BNC** – in this mode of operation your device under test should be connected to the instrument through the BNC terminals. The board applies stimuli and reads out data exclusively through the BNC terminals (Figure 6). In the Crossbar Panel the target device appears as address  $[W=1, B=1]$ . **WARNING:** Please ensure no package is connected in the PLCC68 holder or through the header bank.
3. **Live: BNC to Local** – in this operating regime the instrument's biasing circuitry is disabled and all voltage/current biasing to target devices is provided through the BNC terminals (Figure 7). The Arc platform only performs routing, i.e. directs bias voltages/currents from the BNCs to the selected device (in PLCC68 package or via header banks).
4. **Offline** – mode used to visualize previously acquired measurements through the Arc system. Arc ONE® biasing hardware disabled.

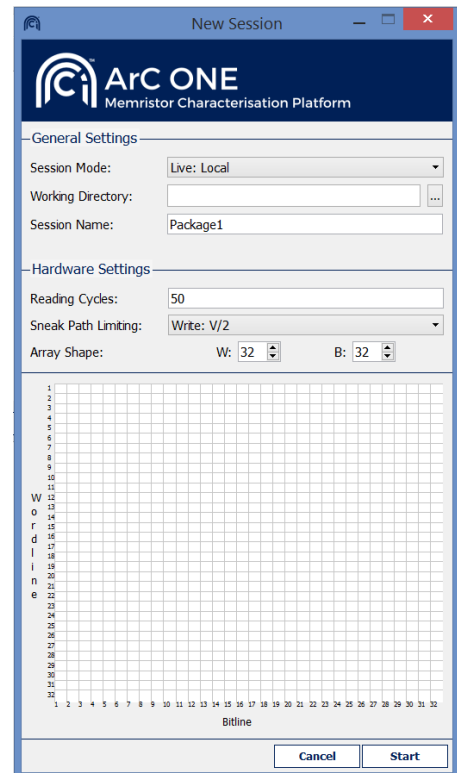


Fig. 4 - New session panel

**Working Directory** entry allows the user to choose the directory in which measurement sessions will be saved. Press the browse button on the right of the entry to navigate. This can be setup later as well.

**Session Name** entry sets the name of the session.

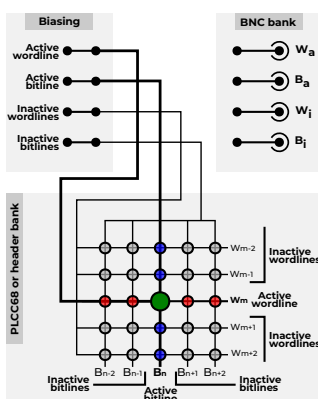


Fig. 5 - Local mode

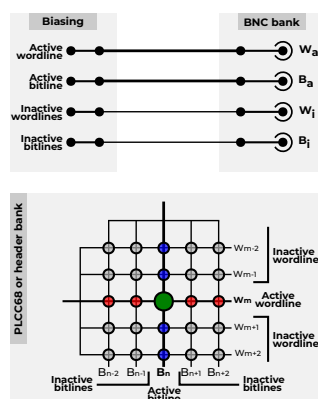


Fig. 6 - External BNC mode

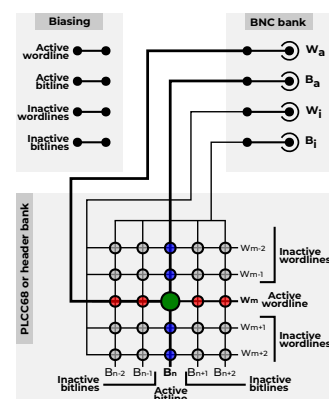


Fig. 7 - BNC-to-Local mode

### Hardware settings

**Reading Cycles:** Every test device resistive state READ measurement is by default an average of  $n$  recorded data points. This entry sets the value of  $n$ . A higher number translates into a slower, but more accurate measurement.  $n=50$  is a reasonable, general purpose choice.

**Sneak Path Limiting** sets up the sneak path mitigation technique employed in selectorless crossbar arrays. The user can choose between  $V/2$ ,  $V/3$ . The following table illustrates how the bias voltage,  $V_w$ , is applied across different devices in the two sneak path mitigation scenarios.

Node	V/2 option	V/3 option
Active wordline	$V_w$	$V_w$
Active bitline	GND	GND
Inactive wordline	$V_w/2$	$V_w/3$
Inactive bitline	$V_w/2$	$V_w/3$

**Array Shape** counters set up the size of the array. Any size is selectable between 1 and 32 word- and bitlines.

### 3.3 Connecting to ArC ONE®

After the new session has been set up, the right hand side of the toolbar should indicate the session mode, and the connection status showing **Disconnected** as below.



Make sure ArC ONE® is connected to the PC via a USB cable, and the board is powered up. A blue LED on the on-board mBED indicates the board is connected to the PC, and red and green LEDs indicate the board is powered up.



From the toolbar (above), select the corresponding COM port of the ArC ONE® board. If you don't know it, you can find it in Windows by going to:

- ▶ Right click *My Computer*;
- ▶ Select *Manage*;
- ▶ On the left hand side, select *Device Manager*;
- ▶ Search for *Ports (COM and LTP)* and expand;
- ▶ Look for a device named: *mbed Serial Port (COMX)*, and make a note of the COM port number.

Return to the GUI and select the respective COM port from the dropdown list, and click **Connect**. If the port is not there, click Refresh and wait for up to 10 seconds. The port should now appear.

Once the connection is successful, the connection status will turn green like below:



If any connection problems occur, please refer to Section 5 of this manual.

### 3.4 Basic Operations

Many basic operations such as reading and writing, as well as data display and device history visualisation are available at a click of a button. As a general rule of thumb, the buttons coloured in **orange** perform invasive operations on the selected device, or range of devices. Buttons coloured in **dark blue** perform non-invasive operations, such as updating ArC ONE® settings or managing data display options.

### 3.4.1 Device selection

Left click the required device on the **Crossbar Panel** to select it. The device will be highlighted by a black outline. Any following invasive operation will be performed on that device.

Hovering the mouse over a crossbar device shows address and resistance information in the small floating information panel.

The address of the currently selected device appears on top of the **Manual Operations** panel, along with its corresponding last measured value of resistance.

Left click and drag in order to select a range of devices. A box with a thick red outline will indicate the selected sub-array. Right click anywhere on the **Crossbar Panel** to toggle the visibility of the box.

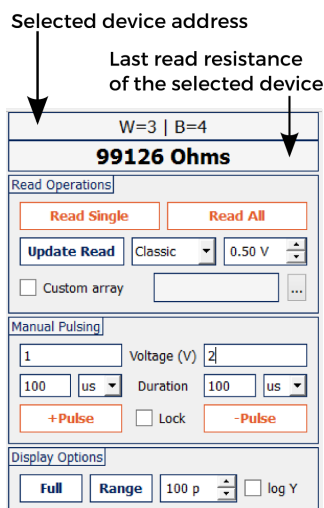


Fig. 8 - Manual operations panel

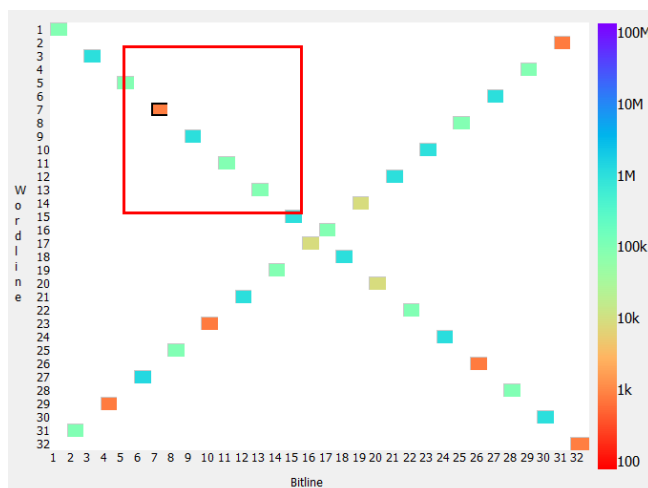


Fig. 9 - Crossbar Panel with range selection

### 3.4.2 Custom arrays

If only a particular set of crosspoints is required for a measurement session, these can be selected on the interface via checking the **Custom Array** checkbox. A file open dialogue will appear which allows the user to select a text file containing the required addresses. *The file should contain the word- and bitlines of the devices separated by a single comma character “,” one pair per line.*

The same open file dialogue will appear if the browse array file button is pressed. The set of device addresses are then highlighted in the Crossbar Panel, while the others are hidden. Any device select, or device operation will be constrained to this set. The devices within the range selected by left clicking and dragging will constitute the target area for any operations carried out via the **Apply to Range** directive.

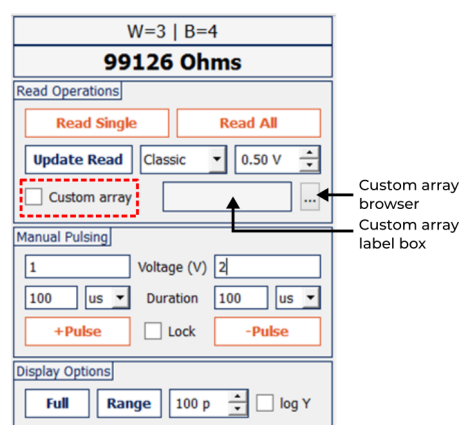


Fig. 10 - Manual Operations — Custom array controls

### 3.4.3 Read operation

In the **Read Operations** sub-panel, click **Read Single** to perform one READ operation on the selected device (highlighted in the **Crossbar Panel**, and listed on top of the **Manual Operations** panel). The new value of resistance is updated there. The **Data Plot** panel will be updated with the new measurement. Click **Read All** to read all devices in the crossbar.



**Update Read** updates the reading method on the ArC board. Select the reading method between the following read-out modes:

1. **Classic**: reads *only* at 0.5 V, suitable for linear resistors, fast;
2. **TIA**: reads at a programmable voltage;
3. **TIA4P**: RECOMMENDED - Kelvin sensing at a programmable voltage;

Select the reading voltage by left-clicking the up and down arrows in the reading voltage counter, or introducing a float number by hand. Remember to click **Update Read** every time the reading method, or reading voltage is changed.

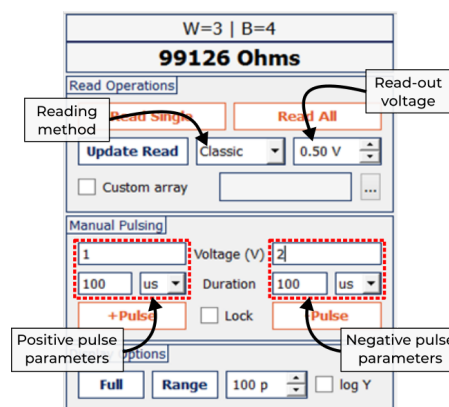


Fig. 11 - Manual Operations panel

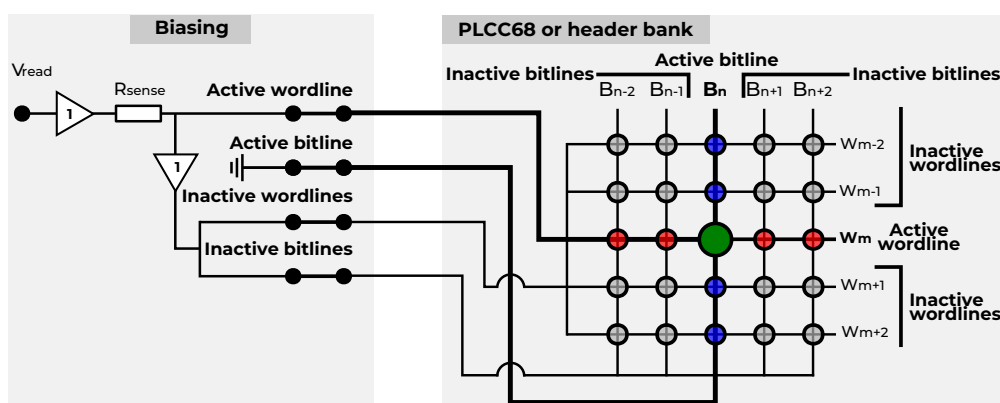


Fig. 12 - Classic read schematic

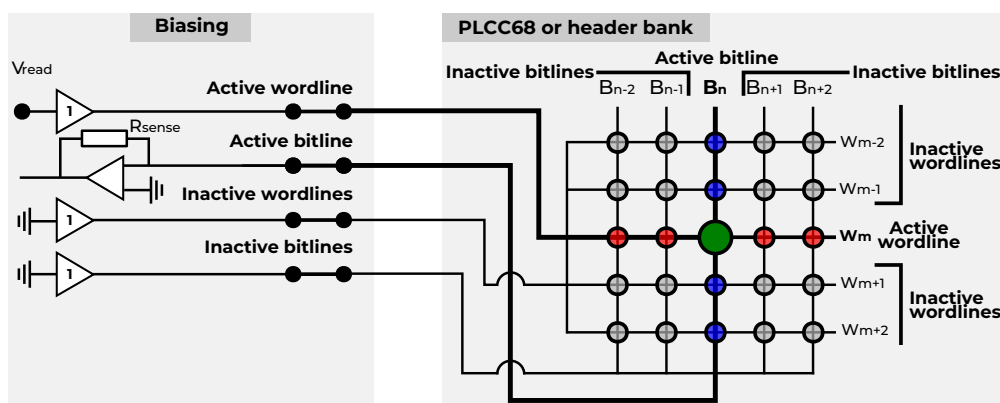


Fig. 13 - TIA-based read schematic

### 3.4.4 Manual Write Programming

In the Manual Pulsing sub-panel, single WRITE pulses can be applied on a selected device.

Click the **+Pulse** to immediately apply a positive voltage pulse, and **-Pulse** to apply a negative pulse. The parameters of the pulse, such as amplitude and duration, can be changed via the entry fields above the corresponding buttons.

A READ operation is automatically performed after each manual pulse. The new measurement is added in the **Data Plot** panel, along with the applied manual pulse.

Checking the Lock checkbox disables the negative pulse parameter entry fields. Clicking **-Pulse** will then apply a negative pulse with the parameters of the positive pulse entry fields. For example: positive pulse parameters are 1 V at 100 ms, negative pulse parameters are 2 V at 1 ms. Clicking **+Pulse** will apply 1 V at 100 ms, **-Pulse** will apply 2 V at 1 ms. After checking the Lock checkbox, clicking **+Pulse** will apply 1 V at 100 ms, and **-Pulse** will apply -1 V at 100 ms.

### 3.4.5 Data display

In the Display Options sub-panel, the user can modify the plot options in the Data Plot panel.

Press **Full** to display all recorded data points for the selected device. Press **Range** to display the last X number of points, where X is set in the adjacent counter. Tick the log Y checkbox to set logarithmic Y axis in the top subplot of the Data Plot panel.

The data plot panel is separated into two subplots as shown in the following figure.

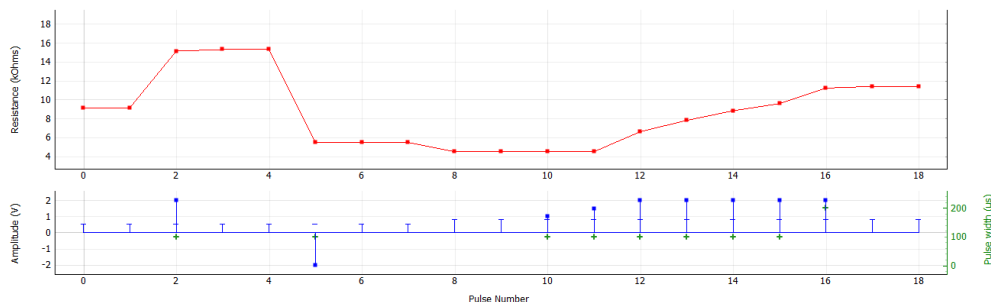


Fig. 14 - The Data Plot panel in operation

Top subplot shows read value of resistance at each pulse number. Bottom subplot shows:

- ▶ Blue horizontal line marker shows the voltage at which the respective resistance data point was measured at.
- ▶ Blue square marker shows a WRITE voltage pulse amplitude
- ▶ Green '+' marker shows the pulse width of a WRITE voltage pulse, shown on the right hand side Y axis.

For example, in figure 14 at pulse #1, the resistance is read at 0.5 V as ~9 kΩ. Next, a 2 V, 100 µs voltage pulse is applied shown at pulse #2. The resistance is then automatically read as 15 kΩ, also at 0.5 V, indicated by the blue horizontal line marker at the same pulse #2. Therefore, a 2 V, 100 µs voltage pulse has changed the resistance of the device as read at 0.5 V, from 9 kΩ to 15 kΩ.

By default the data plot panel shows *resistance* values. This can be changed to either *conductance*, *current* or *absolute current* from the main toolbar.



Additional display options, such as setting custom x and y-axis range, or exporting the figure image files can be accessed by right clicking on the Data Plot panel.

### 3.4.6 Device History

All invasive device operations are logged in the **Device History** panel on left hand side of the interface. Device addresses are added from top to bottom in a chronological order following any operation. The last device address where an operation was performed is underlined. Selecting a device address from the **Device History** panel will also select and display its pulsing history in the **Data Plot** panel.

Single device operations are listed below its corresponding address from top to bottom in a chronological order. These become visible by clicking the dropdown marker.

READ operations are tagged with Read x N, where N is the number of read pulses applied in sequence. WRITE operations are tagged with Pulse x N, where N is the number of manual WRITE pulses applied in sequence.

Advanced pulsing algorithms are tagged with their corresponding name. Double clicking some advanced pulsing algorithm entries displays further measurement results. For example, following a CurveTracer measurement, double clicking the "CurveTracer" history entry will display the resulting IV curve. See Section 3.5 for more information.

### 3.4.7 Saving data

All raw data is saved in standard .csv files by clicking the save button in the toolbar. Every READ or WRITE operation is represented as a line entry in this file, following the format below

Wordline, Bitline, Resistance, Amplitude, Pulse Width, Tag, ReadTag, Read Voltage
---

- ▶ **Wordline** and **Bitline**: target device address.
- ▶ **Resistance**: last read resistance of target device.
- ▶ **Amplitude**: pulse amplitude of operation.
- ▶ **Tag**: type of operation and additional information.
- ▶ **ReadTag**: represents the read type employed for the READ operation. Its format is RX where X is a unique code for the read type.
- ▶ **ReadVoltage**: read voltage used for the READ operation (if any).

The Tag field is of special importance as it identifies the type of operation. Manual read and pulse operations use the following conventions

Tag	Description	Comments
F RX $V_r$	A <b>Read All</b> operation. X represents the read type 0: Classic; 1: TIA; 2: TIA4P. $V_r$ is the read-out voltage.	Data points are not visible in the Device History panel. $V_r$ is saved in the Amplitude column and PulseWidth is always 0.
S RX $V_r$	A <b>Read Single</b> operation. X and $V_r$ as above.	Data point is visible in the Device History panel. PulseWidth is always 0.
P	Singular pulses when using the <b>±Pulse</b> buttons in the <b>Manual Operations</b> panel.	Resistance is the resistance of the device upon a read-out <i>immediately after</i> the pulse.

All other pulsing modules use the TAG\_x format. TAG is a unique identifier assigned to each module. For instance CurveTracer uses the CT tag, Retention uses the RET tag and so on. The x part is a single character either s, i or e; s signals the *start* of the operation and e the *end*. All *intermediate* points are assigned the i character. Additional information for each module is provided in their respective sections. Depending on the module, additional information may be provided in the Tag.

The following plot illustrates a set of operation performed on the device with word- and bitline coordinates 15 and 15 respectively. The resulting dataset is also presented below.

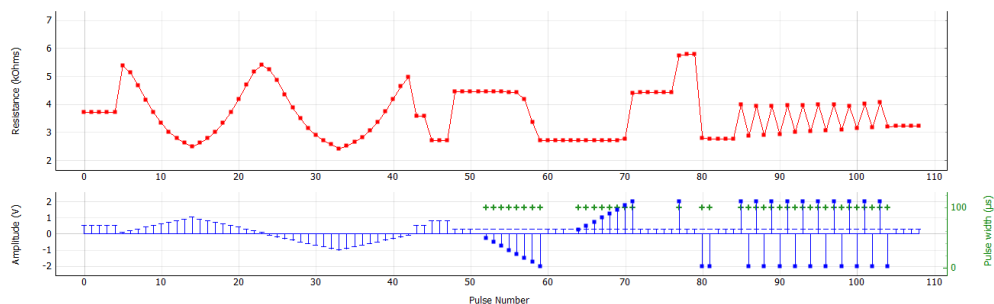


Fig. 15 - Sample measurements for different operations

#	Word	Bit	Res. ( $\Omega$ )	Ampl. (V)	Pulse (s)	Tag	ReadTag	$V_r$ (V)
0	15	15	3710.626	0.5	0	S R2 V=0.5	R2	0.5
1	15	15	3709.371	0.5	0	S R2 V=0.5	R2	0.5
2	15	15	3711.800	0.5	0	S R2 V=0.5	R2	0.5
3	15	15	3711.342	0.5	0	S R2 V=0.5	R2	0.5
4	15	15	3712.748	0.5	0	S R2 V=0.5	R2	0.5

#	Word	Bit	Res. ( $\Omega$ )	Ampl. (V)	Pulse (s)	Tag	ReadTag	V <sub>r</sub> (V)
5	15	15	5387.196	0.095865	0	CT_s	R2	0.095865
6	15	15	5132.203	0.197452	0	CT_i_1	R2	0.197452
7	15	15	4678.331	0.298781	0	CT_i_1	R2	0.298781
8	15	15	4168.121	0.399095	0	CT_i_1	R2	0.399095
9	15	15	3710.786	0.498812	0	CT_i_1	R2	0.498812
10	15	15	3329.797	0.601575	0	CT_i_1	R2	0.601575
11	15	15	3015.440	0.706225	0	CT_i_1	R2	0.706225
12	15	15	2788.292	0.810664	0	CT_i_1	R2	0.810664
13	15	15	2623.501	0.912557	0	CT_i_1	R2	0.912557
14	15	15	2490.076	1.014837	0	CT_i_1	R2	1.014837
15	15	15	2621.308	0.912573	0	CT_i_1	R2	0.912573
16	15	15	2789.779	0.810455	0	CT_i_1	R2	0.810455
17	15	15	3020.242	0.706225	0	CT_i_1	R2	0.706225
18	15	15	3331.286	0.601511	0	CT_i_1	R2	0.601511
19	15	15	3720.155	0.498795	0	CT_i_1	R2	0.498795
20	15	15	4177.835	0.398998	0	CT_i_1	R2	0.398998
21	15	15	4687.421	0.298636	0	CT_i_1	R2	0.298636
22	15	15	5160.943	0.197452	0	CT_i_1	R2	0.197452
23	15	15	5411.013	0.095865	0	CT_i_1	R2	0.095865
24	15	15	5234.892	-0.09978	0	CT_i_1	R2	-0.09978
25	15	15	4851.898	-0.20206	0	CT_i_1	R2	-0.20206
26	15	15	4356.187	-0.30347	0	CT_i_1	R2	-0.30347
27	15	15	3871.069	-0.40329	0	CT_i_1	R2	-0.40329
28	15	15	3491.388	-0.5044	0	CT_i_1	R2	-0.5044
29	15	15	3146.329	-0.60612	0	CT_i_1	R2	-0.60612
30	15	15	2899.183	-0.70682	0	CT_i_1	R2	-0.70682
31	15	15	2710.133	-0.8068	0	CT_i_1	R2	-0.8068
32	15	15	2563.161	-0.90872	0	CT_i_1	R2	-0.90872
33	15	15	2415.091	-1.01092	0	CT_i_1	R2	-1.01092
34	15	15	2515.301	-0.9085	0	CT_i_1	R2	-0.9085
35	15	15	2652.484	-0.80683	0	CT_i_1	R2	-0.80683
36	15	15	2830.457	-0.70664	0	CT_i_1	R2	-0.70664
37	15	15	3060.042	-0.60627	0	CT_i_1	R2	-0.60627
38	15	15	3369.232	-0.50439	0	CT_i_1	R2	-0.50439
39	15	15	3738.675	-0.40321	0	CT_i_1	R2	-0.40321
40	15	15	4194.151	-0.3035	0	CT_i_1	R2	-0.3035
41	15	15	4640.740	-0.20174	0	CT_i_1	R2	-0.20174
42	15	15	4973.099	-0.09959	0	CT_e	R2	-0.09959
43	15	15	3578.096	0.5	0	S R2 V=0.5	R2	0.5
44	15	15	3580.594	0.5	0	S R2 V=0.5	R2	0.5
45	15	15	2714.075	0.8	0	S R2 V=0.8	R2	0.8
46	15	15	2715.643	0.8	0	S R2 V=0.8	R2	0.8
47	15	15	2715.713	0.8	0	S R2 V=0.8	R2	0.8
48	15	15	4449.561	0.3	0	S R2 V=0.3	R2	0.3
49	15	15	4454.619	0.3	0	S R2 V=0.3	R2	0.3
50	15	15	4454.496	0.3	0	S R2 V=0.3	R2	0.3
51	15	15	4453.649	0	0	FF_s	R2	0.3

#	Word	Bit	Res. ( $\Omega$ )	Ampl. (V)	Pulse (s)	Tag	ReadTag	V <sub>r</sub> (V)
52	15	15	4455.347	-0.25	0.0001	FF_i	R2	0.3
53	15	15	4450.094	-0.5	0.0001	FF_i	R2	0.3
54	15	15	4448.665	-0.75	0.0001	FF_i	R2	0.3
55	15	15	4437.407	-1	0.0001	FF_i	R2	0.3
56	15	15	4420.111	-1.25	0.0001	FF_i	R2	0.3
57	15	15	4171.116	-1.5	0.0001	FF_i	R2	0.3
58	15	15	3355.073	-1.75	0.0001	FF_i	R2	0.3
59	15	15	2714.420	-2	0.0001	FF_e	R2	0.3
60	15	15	2717.500	0.3	0	S R2 V=0.3	R2	0.3
61	15	15	2717.707	0.3	0	S R2 V=0.3	R2	0.3
62	15	15	2717.669	0.3	0	S R2 V=0.3	R2	0.3
63	15	15	2717.591	0	0	FF_s	R2	0.3
64	15	15	2719.074	0.25	0.0001	FF_i	R2	0.3
65	15	15	2718.968	0.5	0.0001	FF_i	R2	0.3
66	15	15	2716.181	0.75	0.0001	FF_i	R2	0.3
67	15	15	2715.721	1	0.0001	FF_i	R2	0.3
68	15	15	2713.022	1.25	0.0001	FF_i	R2	0.3
69	15	15	2713.360	1.5	0.0001	FF_i	R2	0.3
70	15	15	2776.728	1.75	0.0001	FF_i	R2	0.3
71	15	15	4390.111	2	0.0001	FF_e	R2	0.3
72	15	15	4414.533	0.3	0	S R2 V=0.3	R2	0.3
73	15	15	4420.807	0.3	0	S R2 V=0.3	R2	0.3
74	15	15	4421.931	0.3	0	S R2 V=0.3	R2	0.3
75	15	15	4438.629	0.3	0	S R2 V=0.3	R2	0.3
76	15	15	4437.45	0.3	0	S R2 V=0.3	R2	0.3
77	15	15	5745	2	1.0E-04	P	R2	0.3
78	15	15	5791.744	0.3	0	S R2 V=0.3	R2	0.3
79	15	15	5794.007	0.3	0	S R2 V=0.3	R2	0.3
80	15	15	2802	-2	1.0E-04	P	R2	0.3
81	15	15	2759	-2	1.0E-04	P	R2	0.3
82	15	15	2763.08	0.3	0	S R2 V=0.3	R2	0.3
83	15	15	2761.165	0.3	0	S R2 V=0.3	R2	0.3
84	15	15	2762.447	0.3	0	S R2 V=0.3	R2	0.3
85	15	15	3999.051	2	0.0001	EN_s	R2	0.3
86	15	15	2861.266	-2	0.0001	EN_i	R2	0.3
87	15	15	3936.899	2	0.0001	EN_i	R2	0.3
88	15	15	2888.566	-2	0.0001	EN_i	R2	0.3
89	15	15	3927.748	2	0.0001	EN_i	R2	0.3
90	15	15	2935.807	-2	0.0001	EN_i	R2	0.3
91	15	15	3960.851	2	0.0001	EN_i	R2	0.3
92	15	15	3010.295	-2	0.0001	EN_i	R2	0.3
93	15	15	3975.576	2	0.0001	EN_i	R2	0.3
94	15	15	3030.883	-2	0.0001	EN_i	R2	0.3
95	15	15	4004.491	2	0.0001	EN_i	R2	0.3
96	15	15	3069.084	-2	0.0001	EN_i	R2	0.3
97	15	15	3993.906	2	0.0001	EN_i	R2	0.3
98	15	15	3098.52	-2	0.0001	EN_i	R2	0.3

#	Word	Bit	Res. ( $\Omega$ )	Ampl. (V)	Pulse (s)	Tag	ReadTag	V <sub>r</sub> (V)
99	15	15	3931.544	2	0.0001	EN_i	R2	0.3
100	15	15	3140.177	-2	0.0001	EN_i	R2	0.3
101	15	15	4010.678	2	0.0001	EN_i	R2	0.3
102	15	15	3161.425	-2	0.0001	EN_i	R2	0.3
103	15	15	4076.823	2	0.0001	EN_i	R2	0.3
104	15	15	3209.966	-2	0.0001	EN_e	R2	0.3
105	15	15	3215.763	0.3	0	S R2 V=0.3	R2	0.3
106	15	15	3215.978	0.3	0	S R2 V=0.3	R2	0.3
107	15	15	3216.013	0.3	0	S R2 V=0.3	R2	0.3
108	15	15	3215.842	0.3	0	S R2 V=0.3	R2	0.3

## 3.5 Advanced pulsing modules

In addition to the manual operations there are several advanced pulsing scripts available from the **Pulsing Modules** panel.

- ▶ **FormFinder** is a generic pulsed voltage ramp that can be also used for electroforming devices. Can be optionally applied up to a specific resistive threshold.
- ▶ **CurveTracer** performs standard pulsed or staircase I-V measurements.
- ▶ **Endurance** cycles a device between two states for any number of cycles and SET/RESET pulses.
- ▶ **Retention** measures the resistance of a device periodically.
- ▶ **SwitchSeeker** applies programming pulses of increasing width and amplitude to extract the operating range and optimal pulsing parameters of a device.
- ▶ **ConvergeToState** uses voltage ramps to gradually set a device to the desired resistive level.
- ▶ **MultiStateSeeker** probes a device for multiple stable resistive states.
- ▶ **ChronoAmperometry** measures the current and resistance of the device while it is being kept under bias.
- ▶ **MultiBias** applies a voltage pulse to multiple wordlines.
- ▶ **VolatilityRead** applies a single pulse and reads the transient response of a device.

Pulsing modules can be enabled by selecting a module from the *Panels* field and clicking the **Add** button. Modules are independent so multiple copies can be enabled at the same time with different biasing parameters. Similarly the active panel can be removed by clicking the **Remove** button. Panel parameters can be saved and recalled later using the **Save** and **Load** buttons. Loading a set of modules parameters from file will not overwrite your active modules but append it as a new tab.

The active module can be applied to selected device, range of devices all the whole crossbar by using the buttons **Apply to One**, **Apply to Range** or **Apply to All** respectively. Please note that applying a module to multiple devices might not be available or not behaving as expected depending on the functionality of the module. Refer to the documentation of each module for more details.

### 3.5.1 FormFinder

**FormFinder** is a versatile pulsing algorithm which applies a pulsed voltage ramp with an option of two stop conditions. After each WRITE pulse, a READ pulse is applied by default. A summary of the operation of this module can be seen in the figure below.

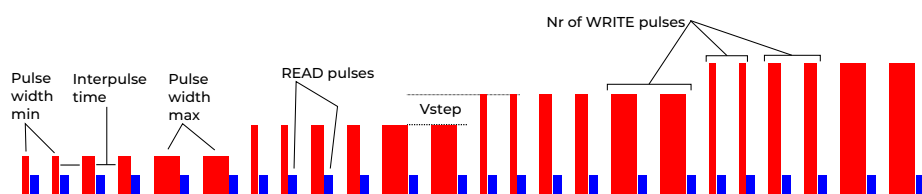


Fig. 16 - Illustration of the FormFinder algorithm

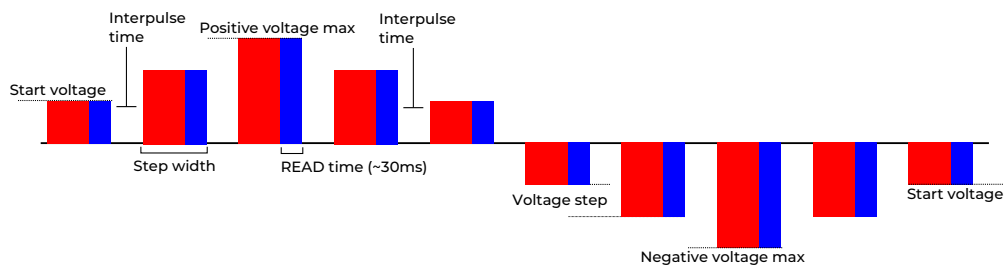
The following parameters are used for this module. A standard pulsed voltage ramp, with one pulse per step can be achieved by setting **Nr of pulses** to 1, and making **Pulse width min (µs)** and **Pulse width max (µs)** equal to the desired pulse width value.

Parameter	Description
Voltage min (V)	Initial voltage of the ramp.
Voltage step (V)	$\Delta V$ between subsequent voltage steps.
Voltage max (V)	Maximum voltage of the ramp; also acts as stop condition.
Pulse width min (µs)	Minimum pulse width that is used.
Pulse width step	Pulse width increment for each subsequent step. This can be either in % of the previous step or a fixed step in µs (see <a href="#">Pulse progression</a> below).
Pulse width max (µs)	Maximum pulse width.
Interpulse time (ms)	Delay between two subsequent WRITE pulses.
Nr of pulses	Number of WRITE pulses per step.
Resistance threshold (Ω)	Halts the ramp when resistance drops below this value. Use 0 to disable.
Resistance threshold (%)	Same as above but as percentage of initial resistance. Only used when <a href="#">Rthr</a> is checked.
pSR	Series resistance: 1: 1 kΩ; 2: 10 kΩ; 3: 100 kΩ; 4: 1 MΩ; 7: disabled.
Negative amplitude	Check this to invert the polarity of the above voltages.
Use Rthr (%)	Enable the use of percentage-based thresholds
Pulse progression	Use multiplicative (%-based) or linear (fixed step) increments for pulse widths.

**Tag:** FF. FormFinder follows the standard FF\_{s,i,e} format.

### 3.5.2 CurveTracer

**CurveTracer** is a standard triangular pulsed IV measurement module, with incorporated current cut-off. During each WRITE pulse, a current measurement is taken towards the end of the pulse.



**Fig. 17 - Illustration of the CurveTracer algorithm**

Parameter	Description
Positive $V_{\max}$ (V)	Maximum positive voltage.
Negative $V_{\max}$ (V)	Maximum negative voltage.
Voltage step (V)	Voltage step for both polarities.
Start voltage (V)	Initial voltage for both polarities (min: 50 mV).
Step width (ms)	Hold time (or pulse width) of each voltage step (min: 1 ms).
Cycles	Number of consecutive I-Vs to be acquired.
Interpulse time (ms)	Delay between adjacent pulses (only for <i>Pulsed</i> bias type).
Positive cutoff (µA)	Positive compliance current (min: 10 µA max: 1000 µA). Set 0 to disable compliance.

Parameter	Description
Negative cutoff ( $\mu\text{A}$ )	Negative compliance current (min: 10 $\mu\text{A}$ max: 1000 $\mu\text{A}$ ). Set 0 to disable compliance.
Halt and Return	When checked the applied bias will be cut-off within 30 $\mu\text{s}$ and return to 0 if current threshold has been exceeded (if $>0$ $\mu\text{A}$ ).
Bias type	Staircase mode set interpulse to 0 ms. In pulsed mode device bias is set to 0 V for the duration of interpulse time.
IV span	Different sweep modes. <i>Only <math>V_{\pm}</math></i> restricts the I-V sweep to that particular polarity. <i>Start towards <math>V_{\pm}</math></i> selects the initial polarity when sweeping both positive and negative voltages.

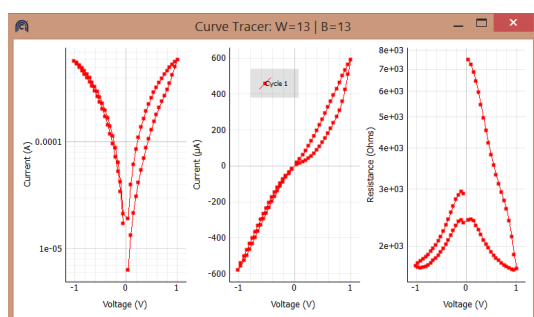


Fig. 18 - CurveTracer results

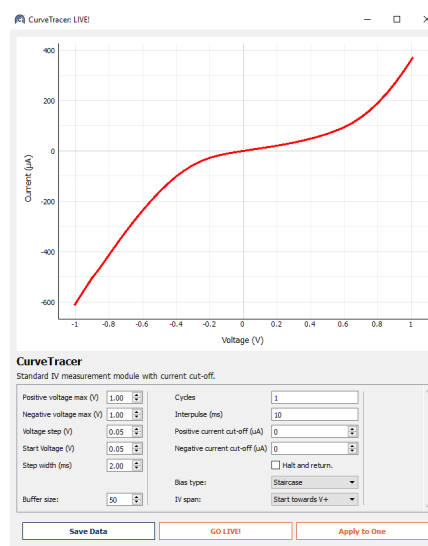


Fig. 19 - CurveTracer – LIVE mode

Following application of the protocol a “CurveTracer” entry will appear in the **Device History** panel. Double click it to visualize the I-V measurement as shown in fig. 18. Right click on the plots and select *Export* to save the figure, or corresponding data.

Pressing the **LIVE** button opens up a panel similar to CurveTracer (fig. 19) offering live display of I-V curves.

**GO LIVE!** – Starts live measurement.

**Apply to One** – Applies a normal CurveTracer measurement with programmable nr of cycles via the corresponding entry field.

**BufferSize** – sets the number of I-V cycles the panel records in its buffer.

**Save Data** – saves all the I-V curves recorded in the internal buffer.

The panel has a persistence of 5 I-V curves which are colour-coded based on recording time: older I-V curves are coloured in increasingly lighter red.

During a live measurement, all parameters can be changed on-the-fly by entering the corresponding values by hand or scrolling with your mouse while hovering on the entry field.

The I-V figure can be scaled with your mouse by scrolling on its axes, and set to auto-scale automatically by pressing the “A” symbol in the bottom left corner of the figure (this symbol appears when hovering over the unscaled figure).

**Tag:** CT. The format of the tag is CT\_{s,i,e}\_X; X is the cycle count.



### 3.5.3 SwitchSeeker

**SwitchSeeker** is a state-of-art analogue resistive switching parameter finder. It automatically extracts the pulse parameters which elicit repeatable analogue resistive switching. It achieves this by applying increasingly invasive alternative polarity pulsed voltage ramps, until the resistance of the device exits a programmable tolerance band. The algorithm consists of two stages: In *stage I* the system attempts to detect the voltage polarity to which the device is most sensitive by applying a series of alternating polarity pulses with progressively higher voltage. This is followed by *stage II* it applies a series of pulsed voltage ramps in alternating polarities in order to switch the device. Stage II requires that the device exhibits some sort of switching behaviour so it relies on stage I for feedback, however if the dependence of the device on applied bias polarity is known it can also be run independently. An illustration of the biasing routine used by SwitchSeeker can be seen below.

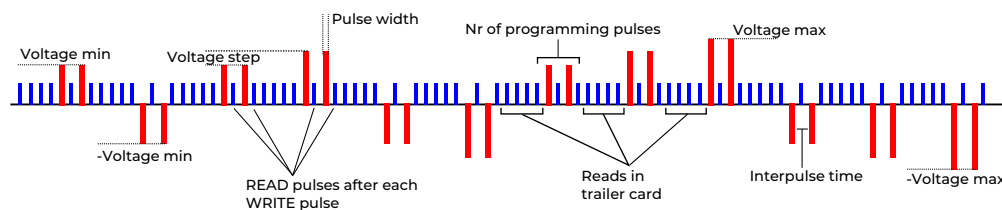


Fig. 20 - Illustration of the SwitchSeeker algorithm

Parameter	Description
Reads in trailer card	The number of read-out pulses before each programming train.
Programming pulses	The number of identical programming pulses.
Pulse duration (ms)	Pulse width of programming pulses.
Voltage min (V)	The initial voltage of each programming voltage ramp.
Voltage step (V)	$\Delta V$ between consecutive programming voltages.
Voltage max (V)	Maximum programming voltage. SwitchSeeker will terminate once this has been reached.
Max switching cycles	Number of consecutive times the device is switched after switching parameters have been determined.
Tolerance band (%)	Tolerance of each resistance measurements as percentage of the initial.
Interpulse time (ms)	$\Delta t$ between consecutive programming pulses.
Resistance threshold ( $\Omega$ )	Maximum valid resistance. At very high resistances ( $> 10 \text{ M}\Omega$ ) measurement noise can be considerable which can lead to unpredictable results.
Skip Stage I	If switching parameters are known, or of no interest, checking this option will make the routine proceed directly to stage II.
Stage II polarity	If the above option is checked this option determines the initial polarity of stage II (that would be otherwise be determined by stage I).
Read after pulse	If checked the routine will also perform an additional READ operation after each programming pulse is applied.

A *SwitchSeeker* entry will appear in the **Device History** panel. Double click it to visualise the analogue resistive switching results. This is a graph depicting the relative resistance change ( $\Delta R/R_0$ ) as a function of programming voltage. For devices with analogue behaviour the curve will feature a gradual change in  $\Delta R/R_0$  whereas predominantly binary devices will exhibit a resistance change above a specific voltage.

**Tag:** ss. SwitchSeeker follows the standard `ss_{s,i,e}` format.

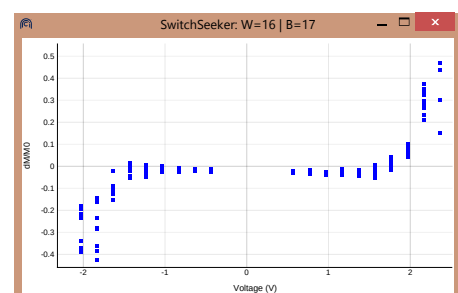


Fig. 21 - SwitchSeeker Results

### 3.5.4 Retention

**Retention** is a standard reliability test. It measures the retention/stability of the current resistive state over time. This can be either be applied to one or many devices which are read in parallel. The read-out voltage used is the one specified in the **Manual Operations** panel. A visualisation of each run is available by double-clicking the *Retention* entry in the **Device History** panel.

Parameter	Description
Read every	Interval between two consecutive read-outs.
Read for	Total duration of the test.

**Tag:** RET. Retention uses the RET\_{s,i,e}\_XXXXXX format where XXXXXX is the absolute system timestamp.

### 3.5.5 Endurance.

**Endurance** is another standard reliability test. It applies alternating polarity voltage pulse trains to toggle the state of single, range or full array of devices between some ON and OFF values. It is possible to set current cut-off values, independent for both half cycles (SET or RESET) by changing the corresponding parameters. A read pulse is applied after each programming pulse.

Parameter	Description
Positive pulse amplitude (V)	Amplitude of the positive polarity pulse.
Negative pulse amplitude (V)	Amplitude of the negative polarity pulse.
Positive pulse width ( $\mu$ s)	Pulse width of the positive polarity pulse.
Negative pulse width ( $\mu$ s)	Pulse width of the negative polarity pulse.
Positive current cut-off ( $\mu$ A)	Current compliance for positive pulses.
Negative current cut-off ( $\mu$ A)	Current compliance for negative pulses.
No. of positive pulses	The amount of positive pulses to be applied per cycle.
No. of negative pulses	The amount of negative pulses to be applied per cycle.
Cycles	Number of repeated SET/RESET operations.
Interpulse time (ms)	Time interval between consecutive pulses.

**Tag:** EN. Endurance follows the standard EN\_{s,i,e} format.

### 3.5.6 Volatility Read

**Volatility Read** applies a single pulse and then measure the transient response of the device. The module begins by applying a single square-wave pulse with parameters specified by the *Pulse Amplitude* and *Pulse Width* fields. Subsequently, the instrument starts measuring the resistive state of the device at its maximum sampling rate of 200 ksps. By default, 100 of these *spot reads* are averaged to yield a single assessment of the resistive state of the DUT, although the user may change that value. Once enough resistive state assessments have been collected (the *Read Batch Size*) the system will interrupt its read-out sequence and transmit data from the microcontroller to the PC, following which the procedure will repeat for as many batches as are required until a stopping condition is met.

Parameter	Description
Pulse amplitude (V)	Amplitude of the programming pulse.
Pulse width ( $\mu$ s)	Pulse width of the above pulse.
Read Batch Size (B)	Number of resistive state assessments.
Average cycles per point	"Spot-reads" to be averaged.
Stop time (s)	Maximum time the assessment should run.

Parameter	Description
Stop t-metric	The target t-metric (for T-test option).
Stop Tol. (%/batch)	The minimum change in resistance (for LinearFit option) to register a stable assessment.
Stop option	Choose between <i>Fixed Time</i> , <i>Linear Fit</i> and <i>T-test</i> (see below).

The module can be configured to use any of the following three stopping conditions.

**Fixed time:** The system will continue reading batches of data until the *Stop time* parameter is reached however once a data batch has started it will finish even if it ends after the prescribed stop time.

**LinearFit:** The system will fit the resistive state of each batch with an affine relation. If the absolute slope measured in % change of resistive state per batch drops below the value specified by the *Stop Tol.* field, the system considers the device to be at rest and the test run ends.

**T-test:** The first and last 25 data points in the batch are processed as two populations of measurements on which the t-test is applied. The t-metric is then computed

$$t = \frac{\mu_1 - \mu_2}{\sqrt{\frac{\sigma_1^2}{n_1} + \frac{\sigma_2^2}{n_2}}}$$

where t is the t-metric,  $\mu$  are the means of the two populations,  $\sigma$  their variances and n the number of samples in each population. The test ends when a batch featuring a t-metric below the user-defined threshold.



- Regardless of stop condition chosen the volatility module will always obey the *Stop Time* condition as a safety precaution.
- When choosing a stopping condition from the drop-down menu the relevant stopping condition text fields are highlighted in red.

**Tag:** VOL. VolatilityRead follows the standard VOL\_{s,i,e} format.

### 3.5.7 STDP

**STDP** performs *Spike-Timing-Dependent Plasticity* measurements by iteratively applying a voltage series given by the difference of two pre- and post- synaptic voltage spikes with configurable delay.



Fig. 22 - STDP module interface

Parameter	Description
Load Pre/Post Spike	Load a voltage series text file which defines the pre- and post-synaptic pulses. This is a comma separated text file with (voltage (V), time (s)) pairs, one per line. The last point <i>MUST</i> be of zero amplitude (0 V).
Identical Spikes	When checked the post-synaptic spike will be identical to the pre-synaptic.
Scale voltage/time	Scale all pre- and post-synaptic spikes in amplitude and duration.
Time step (ms)	Sets a time step which is used when iterating through STDP events.
Only single event	When checked, only the STDP waveform shown in the top right figure is applied, one time, when clicking the <b>Apply to One</b> button.

For example in the figure above, pre- and post- spikes are identical, and their maximum duration is 1 ms. Time step is set to 0.1 ms (henceforth referred to as `timeStep`). By clicking on **Apply to ...**, the experiment will proceed as follows: First, the resulting waveform of Pre-Post with  $dt = 0$  s will be applied, followed by the resulting waveform for  $dt = +timeStep$ , then for  $dt = -timeStep$ , then for  $dt = +2 \times timeStep$ , then for  $dt = -2 \times timeStep$  and so on, until  $dt$  becomes greater than the duration of the longest spike (in this case both pre- and post- are the same at 1 ms).

### 3.5.8 MultiBias

**MultiBias** is used to apply a voltage pulse to multiple active wordlines, or read current from multiple devices in parallel sharing the same bitline.

Parameter	Description
Active Wordlines	Whitespace delimited <i>active</i> wordline addresses.
Active Bitline	Active wordline address. Only <i>one</i> bitline allowed.
WRITE amplitude (V)	Amplitude of the WRITE pulse.
WRITE pulse width (V)	Pulse width of the WRITE pulse.
READ voltage (V)	Voltage used for the READ operation.

There are no **Apply to ...** operations in MultiBias as it inherently requires more than one device to work. The user is instead presented with the **WRITE** and **READ** buttons.

**WRITE:** When pressed, the module will apply a voltage pulse (V) to the selected active wordlines. The active bitline is grounded, and all other inactive word- and bit-lines will receive  $V/2$ .

**READ:** When pressed, the module will apply the read voltage to the active wordlines, then read and display the current on the active bitline in the Current on Active Bitline entrybox. During this operation, all inactive word- and bit-lines are held at virtual-GND.

The WRITE operation consists of the following stages:

1. READ of all devices on the active bitline at the reading voltage set in the **Manual Operations** panel;
2. Application of the WRITE pulse ( $V_{write}$ );
3. READ of all devices on the active bitline at the reading voltage set in the **Manual Operations** panel; These pulses and subsequent reads are logged in the **Data Plot** and **Device History** panels for each device on the active bitline. Devices on the active wordline will have received the full amplitude of  $V_{write}$ , whilst the ones on the inactive wordlines will have received  $V_{write}/2$ .

### 3.5.9 ConvergeToState

**ConvergeToState** allows the user the program a memristor to a user-defined resistive state. It employs an algorithm similar to FormFinder to deliver programming pulse ramps so as to gradually shift the resistance of the device to the desired level. In contrast to FormFinder this is not limited to a specific low resistance. ConvergeToState will instead try to “guess” the correct polarity of by observing the transient response of the resistance and will switch polarities if current resistance diverges away from the target. In order to avoid never-ending loops the number of possible reversals is limited to five (5).

Parameter	Description
Target R ( $\Omega$ )	Desired resistive level.
Rt tolerance (%)	Sets the target resistance tolerance. If current resistance is within the specified percentage of the target the algorithm terminates.
Initial polarity	Selects the initial voltage polarity. This can be a useful hint to the algorithm to avoid unnecessary polarity switches.
Ro tolerance (%)	Sets the initial resistance tolerance. Any $\Delta R$ below the specified value (in % of the initial) is <i>not</i> registered as deviation from the initial state.
PW min/step/max (ms/%/ms)	Programming pulse width characteristics. Before switching voltage amplitudes the system will increase the pulse width in % of the minimum until the maximum value has been reached.
Voltage min/step/max (V)	Programming amplitude characteristics. The system will scan from min to max. Once max has been reached the algorithm will terminate.
Interpulse (ms)	Interval between two consecutive pulses.
Pulses	Number of pulses per programming step.

**Tag:** CTS. ConvergeToState follows the standard CTS\_{s,i,e} format.

### 3.5.10 ChronoAmperometry

**ChronoAmperometry** measures the current and resistance of a device continuously while it is being kept under bias.

Parameter	Description
Bias (V)	Applied voltage bias.
Bias duration (ms)	Duration of the applied pulse.
Number of reads	Times the device will be sampled while under bias (min: 2).

**Tag:** CRA. ChronoAmperometry follows the standard CRA\_{s,i,e} format.

### 3.5.11 MultiStateSeeker

**MultiStateSeeker** is used to assess multiple stable resistive states on devices that exhibit analogue behaviour. It combines the polarity inference ability of the **SwitchSeeker** for polarity inference with additional code to switch the device to progressively lower or higher non-volatile states by programming it with controlled voltage pulses.

**MultiStateSeeker** consists of three phases that can be applied on an unknown device so as to assess the number of available states within a user-programmable tolerance threshold. *Phase I* essentially determines the sensitivity of the device to the polarity of the applied bias, not unlike to how **SwitchSeeker** does. Then, on *Phase II*, the device is driven to a low (or high resistive) state that is stable enough to be regarded as its “initial” state. The baseline criterion is either a linear fit or a t-test. This is, finally, followed by *Phase III* where the actual state assessment is performed. Using the polarity extracted from phase I a programming pulse is applied followed by two sets of READ pulse trains separated by a user-defined short-term retention interval. If current state is clearly

separated by the previous by up to  $9\sigma$  then the state is registered. Otherwise the number of pulses and subsequently the amplitude is increased until it does. Once a maximum voltage has been reached the measurement terminates.

The third phase of [MultiStateSeeker](#) presents a clickable entry (*MultiState Calculation*) in the **Device History** panel that displays a summary of calculated states.

### Parameters of Phase I

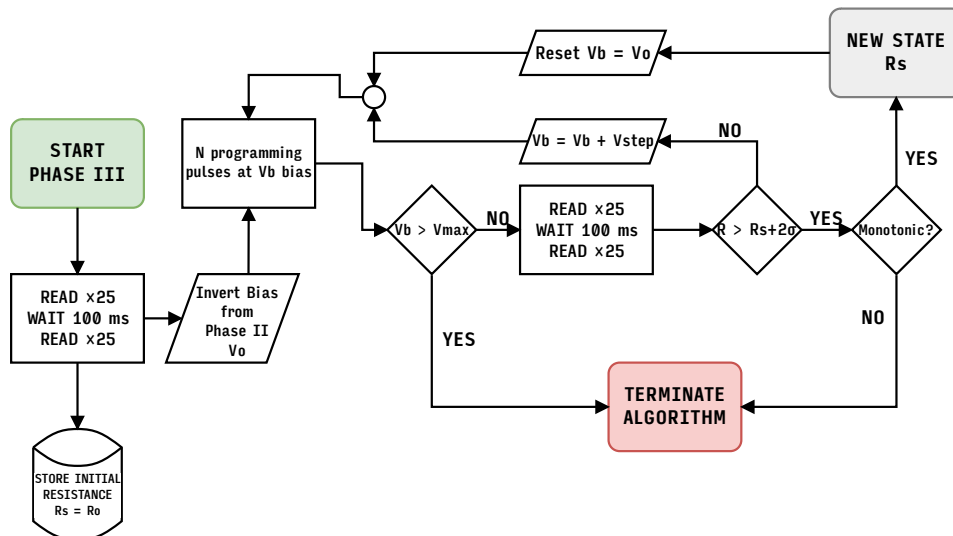
The user parameters in Phase I follow the same semantics as those in [SwitchSeeker](#).

### Parameters of Phase II

Parameter	Description
Pulse voltage (V)	Bias used to drive device to its baseline state.
Pulse width (ms)	Pulse width of pulse.
State mode	Can be either <i>As calculated</i> to use the polarity inferred from Phase I or <i>Inverse polarity</i> for the opposite value.
Stability test	The type of test to be used to evaluate stability of baseline; either <i>Linear</i> or <i>T-test</i> .
Max time (s)	Timeout for above test.
Tolerance or t-metric (%/-)	Stability criterion for linear fit and t-test respectively.

### Parameters of Phase III

Parameter	Description
Mode	Parameter to sweep for assessment; can be either <i>voltage sweep</i> , <i>pulse width sweep</i> or <i>programming sweep</i> .
Reads	Number of pulses in READ train. Two READ trains separated by the retention interval (see below) will be applied after each programming step.
Max. programming pulses	The maximum number of programming pulses to use to switch the state of the device. Only available in <i>voltage</i> and <i>pulse width</i> modes.
Voltage bias (V)	Voltage bias to be applied for programming. Only available in <i>pulse width</i> and <i>programming</i> modes.
Voltage/PW/Pulses min/step/max	The sweep parameters depending on the active mode. Voltages in V; pulse widths in ms.
Interpulse (ms)	Interval between consecutive programming pulses.
Retention time (ms or s)	Delay between consecutive READ trains.
Std. deviations	Number of standard deviations that are required to separate consecutive resistive states ( $1\sigma$ : very dense states $\rightarrow 9\sigma$ : very coarse states)
Monotonicity	How the algorithm should treat resistance reversals (e.g. resistance decreases when the overall trend is increasing). <i>Stop on reversal</i> : stops immediately; <i>Move to next step</i> : apply the next pulse in sequence; <i>Ignore</i> : do nothing.

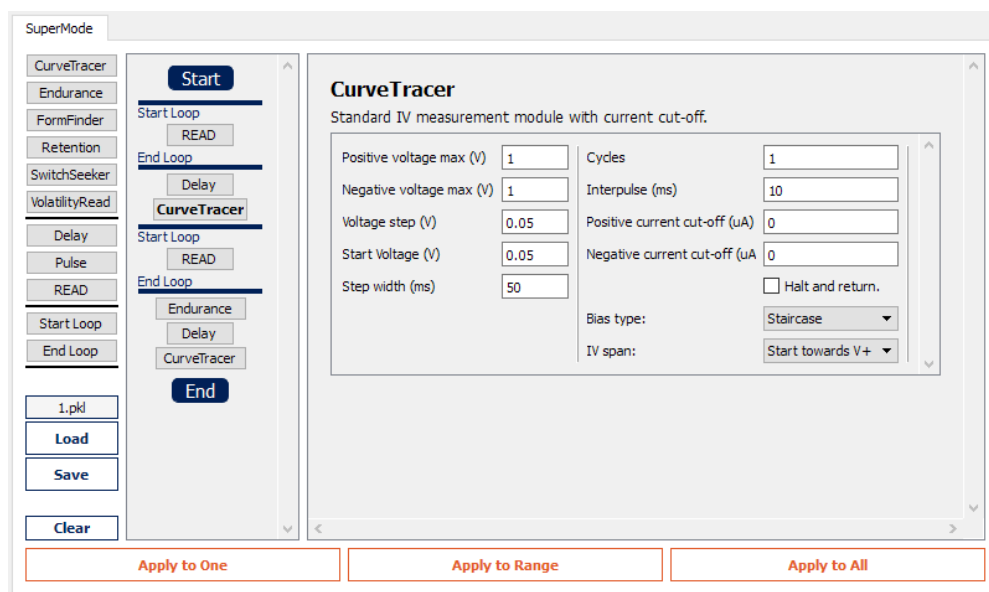


**Fig. 23** - MultiStateSeeker phase III block diagram for 25 reads, 100 ms retention and  $2\sigma$  confidence intervals.

**Tag:** MSS1 to MSS3 for each respective state. Each one follows the standard MSSX\_{s,i,e} format.

## 3.6 SuperMode

**SuperMode** allows users to create chains of measurement modules to better fit your characterisation procedures. Instead of applying consecutive different pulsing modules by hand, simply create an experiment chain with full flexibility. The module can be found as a bold entry in the drop-down list on the [Advanced Modules Panel](#).



**Fig. 24** - SuperMode panel overview

The left-hand side column contains the available modules built in the platform, along with basic ones such as time delay (Delay), single voltage pulse and single READ operation. Furthermore, **Start Loop** and **End Loop** indicators can be utilised as well.

You can drag-and-drop your required modules onto the next column on the right (the chain column), between the blue **Start** and **End** markers. Rearrange them also by drag-and-drop, and discard unwanted ones by dropping them outside the chain column. When applying such an experiment chain to your devices, the instructions will be executed from top to bottom (**Start** to **End**).

Double click on a positioned module in the chain column to modify the procedure parameters. The selected module will be highlighted in the chain column. Double click on the **Start Loop** indicator to set the number of

repetitions of the block contained. Nested loops are possible, and the system will check the order of the **Start Loop** and **End Loop** indicators for consistency before starting an experiment.

You can **Save** and later **Load** measurement chains via the corresponding buttons. The **Clear** button will delete all entries from the chain column.

## 4 Example use cases

[1] A. Serb, et. al. “*Unsupervised learning in probabilistic neural networks with multi-state metal-oxide memristive synapses*”, **Nature Communications**, 2016

[2] I. Gupta, et. al. “*Real-time encoding and compression of neuronal spikes by metal-oxide memristors*”, **Nature Communications**, 2016

[3] R. Berdan, et. al. “*A  $\mu$ Controller-based system for interfacing selectorless RRAM crossbar arrays*”, **IEEE Transactions on Electron Devices**, 62(7), 2190—2196, 2015

[4] R. Berdan, et. al. “*Emulating short-term synaptic dynamics with memristive devices*”, **Scientific Reports**, 6, 10.1038, 2016

## 5 Troubleshooting

### 5.1 Connection issues

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In the case when the ArC ONE® board does not connect to the ArC GUI, try the following:

1. Make sure the board is powered by checking the LED power indicators.
2. Make sure the board is connected to the PC. A blue LED next to the mBED USB connector should be ON. If the mBED is connected and no blue LEDs are on, contact us.
3. Unplug the USB cable and plug it back in.
4. Restart the GUI (make sure you save any live data).

In the case when the ArC GUI does not receive correct data from the ArC board, save your data, reset the mBED and restart the GUI.





